

Product Brief PE42632 Flip Chip

SP6T UltraCMOS™ 2.70 V Switch 100 - 3000 MHz, 50 Ω

Figure 1. Functional Diagram

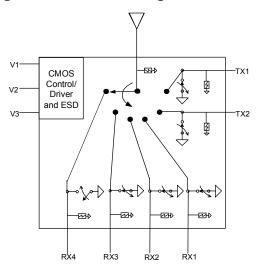


Figure 2. Die Top View

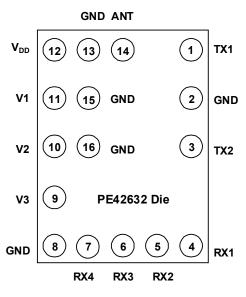


Figure 3. Package Type: Flip Chip



Features

- Three pin CMOS logic control with integral decoder/driver
- Low TX insertion loss: 0.55 dB at 900 MHz, 0.60 dB at 1900 MHz
- TX RX Isolation of 38 dB at 900 MHz. 31 dB at 1900 MHz
- Low harmonics: $2f_0 = -90$ dBc and $3f_0 = -82 \text{ dBc}$
- 1500 V HBM ESD tolerance all ports
- 41 dBm P1dB, TX paths
- · No blocking capacitors required
- RoHS compliant lead-free solder balls

Product Description

The PE42632 is a HaRP™-enhanced SP6T RF Switch developed on the UltraCMOS™ process technology. This 50 Ω switch addresses the specific design needs of the Quad-Band GSM Handset Antenna Switch Module Market. On-chip CMOS decode logic facilitates three-pin low voltage CMOS control. High ESD tolerance of 1500 V at all ports, no blocking capacitor requirements and on-chip SAW filter over-voltage protection devices make this the ultimate in integration and ruggedness.

Peregrine's HaRP™ technology enhancements deliver high linearity and exceptional harmonics performance. It is an innovative feature of the UltraCMOS™ process, providing performance superior to GaAs with the economy and integration of conventional CMOS.

Table 1. Electrical Specifications @ +25 °C, V_{DD} = 2.5 - 2.8 V (Z_{S} = Z_{L} = 50 Ω)

Parameter	Conditions	Typical	Units
Operational Frequency		100-3000	MHz
Insertion Loss ¹	ANT - TX - 850 / 900 MHz ANT - TX - 1800 / 1900 MHz ANT - RX - 850 / 900 MHz ANT - RX - 1800 / 1900 MHz	0.55 0.6 0.9 1.15	dB dB dB dB
Isolation	TX - RX - 850 / 900 MHz TX - RX - 1800 / 1900 MHz TX - TX - 850 / 900 MHz TX - TX - 1800 / 1900 MHz	38 31 31 26	dB dB dB dB
Return Loss	850 / 900 MHz 1800 / 1900 MHz	23 22	dB
2nd Harmonic ^{2,3}	35 dBm TX Input - 850 / 900 MHz 33 dBm TX Input - 1800 / 1900 MHz	-90 -89	dBc
3rd Harmonic ^{2,3}	35 dBm TX Input - 850 / 900 MHz 33 dBm TX Input - 1800 / 1900 MHz	-82 -80	dBc
Switching Time ⁴	50% Control Logic to 90% RF	1	μs

Notes:

- 1. Insertion loss specified with optimal ANT impedance matching.
- 2. Measured in Pulsed Wave Mode.
- 3. Assumes RF input duty cycle of 50% and 4620 $\mu s,$ measured per 3GPP TS 45.005
- 4. Power on any port must not exceed +20 dBm during switching event.

Table 2. Operating Ranges

Parameter	Symbol	Min	Тур	Max	Units
Temperature range	T _{OP}	-40		+85	°C
V _{DD} Supply Voltage	V_{DD}	2.5	2.70	2.8	V
I _{DD} Power Supply Current (V _{DD} = 2.75 V)	I _{DD}		13	20	μΑ
TX input power ⁵ (VSWR ≤ 3:1) 824-915 MHz				+35	d Date
TX input power ⁵ (VSWR ≤ 3:1) 1710-1910 MHz	P _{IN}			+33	dBm
RX input power ⁵ (VSWR =1:1)	P _{IN}			+20	dBm
Control Voltage High	V _{IH}	0.7 x V _{DD}			V
Control Voltage Low	V _{IL}			0.3 x V _{DD}	V

Note: 5. Assumes RF input period of 4620 µs and duty cycle of 50%.

Table 3. Absolute Maximum Ratings

Symbol	Parameter/Conditions Min		Max	Units
V_{DD}	Power supply voltage	-0.3	4.0	V
Vı	Voltage on any DC input -0		V _{DD} + 0.3	V
T _{ST}	Storage temperature range	-65	+150	°C
T _{OP}	Operating temperature range	-40	+85	°C
	TX input power $(50 \Omega)^{6,7}$ 824-915 MHz		+38	
Ρ _{IN} (50 Ω)	TX input power (50 Ω) ^{6,7} 1710-1910 MHz		+36	dBm
	RX input power $(50 \Omega)^7$		+23	
P _{IN} (∞ :1)	TX input power (VSWR = $(\infty : 1)^{6,7}$ 824-915 MHz		+35	dBm
1 IN (** . 1)	TX input power (VSWR = $(\infty : 1)^{6,7}$ 1710-1910 MHz		+33	dBm
V _{ESD}	ESD Voltage (HBM, MIL_STD 883 Method 3015.7)		1500	V
	ESD Voltage (MM, JEDEC, JESD22-A114-B)		100	V

6. Assumes RF input period of 4620 µs and duty cycle of 50%.

Part performance is not guaranteed under these conditions. Exposure to absolute maximum conditions for extended periods of time may adversely affect reliability. Stresses in excess of absolute maximum ratings may cause permanent damage.

^{7.} V_{DD} within operating range specified in Table 2.



Table 4. Pin Descriptions

Pin No.	Pin Name	Description
1	TX18	RF I/O – TX1
2	GND	TX Ground
3	TX2 ⁸	RF I/O – TX2
4	RX18	RF I/O – RX1
5	RX2 ⁸	RF I/O – RX2
6	RX3 ⁸	RF I/O – RX3
7	RX4 ⁸	RF I/O – RX4
8	GND	RX Ground
9	V3	Switch control input, CMOS logic level
10	V2	Switch control input, CMOS logic level
11	V1	Switch control input, CMOS logic level
12	V_{DD}	Supply
13	GND	DC Ground
14	ANT ⁸	RF Common - Antenna
15	GND	DC Ground
16	GND	DC Ground

Note:

8. Blocking capacitors needed only when non-zero DC voltage present

Figure 4. Pad Configuration (Top View)

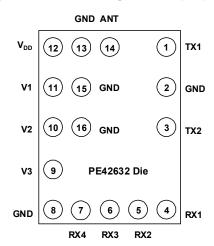


Table 5. Truth Table

Path	V3	V2	V1
ANT - TX1	0	1	1
ANT - TX2	0	0	1
ANT – RX1	1	1	0
ANT – RX2	0	1	0
ANT – RX3	1	0	0
ANT – RX4	0	0	0

Electrostatic Discharge (ESD) Precautions

When handling this UltraCMOS™ device, observe the same precautions that you would use with other ESD-sensitive devices. Although this device contains circuitry to protect it from damage due to ESD, precautions should be taken to avoid exceeding the specified rating.

Latch-Up Avoidance

Unlike conventional CMOS devices, UltraCMOS™ devices are immune to latch-up.

Table 6. Ordering Information

Order Code	Description	Package	Shipping Method
PE42632DTI	PE42632-DIE-D	Bumped Wafer on Film Frame	Wafer (Gross Die / Wafer Quantity)
PE42632DBI	PE42632-DIE-400G	Die in Waffle Pack	400 Dice / Waffle Pack
EK-42632-01	PE42632-DIE-1H	Evaluation Kit	1/ box



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Data Sheet Identification

Advance Information

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Preliminary Specification

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Product Specification

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